

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination BEAN ET AL.	
			Examiner USMAN KHAN	Art Unit 2622	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,480,624	11-2002	Horie et al.	382/165
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	D	US-			
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	L	US-			
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**NON-PATENT DOCUMENTS**

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